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## \*BIBDATASHEET\*

CONFIRMATION NO. 2275

Bib Data Sheet

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| SERIAL NUMBER<br>10/826,954 | FILING DATE<br>04/15/2004<br><br>RULE | CLASS<br>324 | GROUP ART UNIT<br>2829 | ATTORNEY DOCKET NO.<br>2001 P 17353 US |
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APPLICANTS

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\*\* CONTINUING DATA \*\*\*\*\*  
 This application is a CON of PCT/DE02/03830 10/11/2002  
*on*

\*\* FOREIGN APPLICATIONS \*\*\*\*\*  
 GERMANY 101 50 291.5 10/15/2001  
*on*

IF REQUIRED, FOREIGN FILING LICENSE GRANTED  
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|  |  |                                |                        |                       |                            |
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| Foreign Priority claimed<br>35 USC 119 (a-d) conditions met<br>Verified and Acknowledged | <input checked="" type="checkbox"/> yes <input type="checkbox"/> no<br><input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance<br><i>on</i><br>Examiner's Signature | STATE OR<br>COUNTRY<br>GERMANY | SHEETS<br>DRAWING<br>1 | TOTAL<br>CLAIMS<br>20 | INDEPENDENT<br>CLAIMS<br>3 |
|--|--|--------------------------------|------------------------|-----------------------|----------------------------|

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 25962  
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TITLE  
 Probe needle for testing semiconductor chips and method for producing said probe needle

|                                   |   |   |
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